Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/701,430	YAMADA ET AL.
Examiner	Art Unit
Hien Tran	1764

SEARCHED					
Class	Subclass	Date	Examiner		
422	171, 177, 179, 180	4/26/2004	нт		
updated	search	8/10/2004	нт		
updated	search	2/16/2005	нт		
updated	search	8/5/2005	нт		
updated	search	2/10/2006	нт		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
iEast Image class/subclass search / check related case 09/604,660	4/26/2004	нт	
updated search/ Inventors' names search / text serach	2/16/2005	нт	
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